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High-Current, Half-Bridge, Gate-Driver IC

The FAN73912 is a monolithic half bridge gate-drive IC designed for high-voltage and high-speed driving for MOSFETs and IGBTs that operate up to +1200 V.

The advanced input filter of HIN provides protection against short-pulsed input signals caused by noise.

An advanced level-shift circuit offers high-side gate driver operation up to VS=-9.8 V (typical) for VBS=15 V. The UVLO circuit prevents malfunction when VCC and VBS are lower than the specified threshold voltage.

Output drivers typically source and sink 2 A and 3 A, respectively.

Features

- Floating Channel for Bootstrap Operation to +1200 V
- Typically 2 A/ 3 A Sourcing/Sinking Current Driving Capability for Both Channels
- Gate Driver Supply (VCC) Range from 12 V to 20 V
- Separate Logic Supply (VDD) Range from 3 V to 20 V
- Extended Allowable Negative VS Swing to -9.8 V for Signal Propagation at VCC=VBS=15 V
- Built-in Cycle-by-Cycle Edge-Triggered Shutdown Logic
- Built-in Shoot-Through Protection Logic
- Common-Mode dv/dt Noise Canceling Circuit
- UVLO Functions for Both Channels
- Built-in Advanced Input Filter
- Matched Propagation Delay Below 50 ns
- Outputs in-Phase with Input Signal
- Logic and Power Ground +/- 10 V Offset

Typical Applications

- Industrial Motor Driver
- UPS
- Solar Inverter
- Ballast
- General-Purpose Half-Bridge Topology.



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PACKAGE PICTURE



Wide 16-SOIC

MARKING DIAGRAM



ORDERING INFORMATION

| Device | Package | Packing Method | | | |
|--|-----------------|-------------------|--|--|--|
| FAN73912MX ⁽¹⁾ | Wide16- SOIC | Tape & Reel | | | |
| 1. This device passed wave-soldering test by | | | | | |

 This device passed wave-soldering test by JESD22A-111



Figure 1. Application Schematic – Adjustable Option



Figure 2. Simplified Block Diagram



| Pin No. | Pin Name | Description | |
|---------|-----------------|--|--|
| 1 | LO | Low-Side Driver Output | |
| 2 | COM | Low-Side Driver return | |
| 3 | VCC | Low-Side Supply Voltage | |
| 4 | NC | No Connection | |
| 5 | NC | No Connection | |
| 6 | Vs | High-Voltage Floating Supply Return | |
| 7 | V _B | High-Side Floating Supply | |
| 8 | НО | High-Side Driver Output | |
| 9 | NC | No Connection | |
| 10 | NC | No Connection | |
| 11 | V _{DD} | Logic Supply Voltage | |
| 12 | HIN | Logic Input for High-Side Gate Driver Output | |
| 13 | SD | Logic Input for Shutdown | |
| 14 | LIN | Logic Input for Low-Side Gate Driver Output | |
| 15 | V _{SS} | Logic Ground | |
| 16 | NC | No Connection | |

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MAXIMUM RATINGS (Note 2)

 $T_{4}=25^{\circ}$ C. unless otherwise specified. All voltage parameters are referenced to COM unless otherwise stated in the table

| Symbol | Parameter | Min. | Max. | Unit | |
|-------------------------------|---------------------------------------|---|----------------------|------|--|
| V _B | High-Side Floating Supply Voltage | -0.3 | 1225.0 | V | |
| Vs | High-Side Floating Offset Voltage | V _B - 25 | V _B +0.3 | V | |
| V _{HO} | High-Side Floating Output Voltage | V _S -0.3 | V _B +0.3 | V | |
| V _{cc} | Low-Side Supply Voltage | -0.3 | 25 | V | |
| V _{LO} | Low-Side Floating Output Voltage | -0.3 | V _{CC} +0.3 | V | |
| V _{DD} | Logic Supply Voltage | V _{SS} -0.3 | V _{SS} +25 | V | |
| V _{SS} | Logic GND | V _{DD} -25 | V _{DD} +0.3 | V | |
| V _{IN} | Logic Input Voltage (HIN, LIN and SD) | V _{SS} + V _{DD} -25.3 | V _{DD} +0.3 | V | |
| dVs/dt | Allowable Offset Voltage Slew Rate | | ±50 | V/ns | |
| P _D (Note 3, 4, 5) | Power Dissipation | | 1.3 | W | |
| θ _{JA} | Thermal Resistance | | 95 | °C/W | |
| TJ | Junction Temperature | | 150 | °C | |
| T _{STG} | Storage Temperature | -55 | 150 | °C | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device 2. functionality should not be assumed, damage may occur and reliability may be affected. Mounted on 76.2 x 114.3 x 1.6 mm PCB (FR-4 glass epoxy material).

3.

4. Refer to the following standards: JESD51-2: Integral circuit's thermal test method environmental conditions, natural convection; JESD51-3: Low effective thermal conductivity test board for leaded surface-mount packages.

5. Do not exceed maximum power dissipation (P_D) under any circumstances.

RECOMMENDED OPERATING CONDITIONS

All voltage parameters are referenced to COM.

| Symbol | Parameter | Min. | Max. | Unit |
|-----------------|--|---------------------------------------|---------------------|------|
| V _B | High-Side Floating Supply Voltage | V _s +12 | V _S +20 | V |
| Vs | High-Side Floating Supply Offset Voltage | 8-V _{CC} | 1200 | V |
| V _{HO} | High-Side (HO) Output Voltage | Vs | V _B | V |
| V _{CC} | Low-Side Supply Voltage | 12 | 20 | V |
| V _{LO} | Low-Side (LO) Output Voltage | 0 | V _{cc} | V |
| V _{DD} | Logic Supply Voltage | V _{SS} +3 | V _{SS} +20 | V |
| V _{SS} | Logic Ground (Note 6) | -10 | 10 | V |
| V _{IN} | Logic Input Voltage (HIN, LIN, SD) | V _{SS} + V _{DD} -20 | V _{DD} | V |
| T _A | Ambient Temperature | -40 | +125 | °C |

6. When V_{DD} <10 V, the minimum V_{SS} offset is limited to - V_{DD} .

STATIC ELECTRICAL CHARACTERISTICS

 $V_{BIAS}(V_{CC}, V_{BS}, V_{DD}) = 15.0 \text{ V}, T_A = 25 \text{ °C}, unless otherwise specified. The V_{IH}, V_{IL} and I_{IN} parameters are referenced to V_{SS} and are applicable to respective input leads: HIN, LIN and SD. The V_O and I_O parameters are referenced to V_S and COM and are applicable to the respective output leads: HO and LO. The V_{DDUV} parameters are referenced to COM. The V_{BSUV} parameters are referenced to V_{S1,2,3}.$

| Symbol | Parameter | Condition | Min. | Тур. | Max. | Unit |
|--------------------|---|---|------|------|------|------|
| LOW-SIDE | POWER SUPPLY SECTION | • | | • | • | |
| locc | Quiescent V _{cc} Supply Current | $V_{IN}=0$ V or V_{DD} | | 170 | 300 | μA |
| I _{QDD} | Quiescent V _{DD} Supply Current | $V_{IN}=0$ V or V_{DD} | | | 10 | μA |
| I _{PCC} | Operating V _{cc} Supply Current | f _{IN} =20 kHz, rms V _{IN} =15V _{PP} | | 650 | 950 | μA |
| I PDD | Operating V _{DD} Supply Current | f _{IN} =20 kHz, rms V _{IN} =15V _{PP} | | 2 | | μA |
| I _{SD} | Shutdown Supply Current | S _D =V _{DD} | | 30 | 50 | μA |
| V _{CCUV+} | V _{cc} Supply Under-Voltage Positive-Going Threshold Voltage | V _{cc} =Sweep | 9.7 | 11.0 | 12 | V |
| V _{CCUV-} | V _{CC} Supply Under-Voltage Negative-Going Threshold Voltage | V _{cc} =Sweep | 9.2 | 10.5 | 11.4 | V |
| V _{CCUVH} | V _{CC} Supply Under-Voltage Lockout Hysteresis Voltage | V _{cc} =Sweep | | 0.5 | | V |
| BOOTSTR | APPED SUPPLY SECTION | I | | | | |
| I _{QBS} | Quiescent V _{BS} Supply Current | $V_{IN}=0$ V or V_{DD} | | 50 | 100 | μA |
| I _{PBS} | Operating V _{BS} Supply Current | f _{IN} =20 kHz, rms value | | 550 | 850 | μA |
| V _{BSUV+} | V _{BS} Supply Under-Voltage Positive-Going Threshold Voltage | V _{BS} =Sweep | 9.7 | 11.0 | 12.0 | V |
| V _{BSUV-} | V _{BS} Supply Under-Voltage Negative-Going Threshold Voltage | V _{BS} =Sweep | 9.2 | 10.5 | 11.4 | V |
| V _{BSUVH} | V _{BS} Supply Under-Voltage Lockout Hysteresis Voltage | V _{BS} =Sweep | | 0.5 | | V |
| I _{LK} | Offset Supply Leakage Current | V _B =V _S =1200 V | | | 50 | μA |
| INPUT Log | ic SECTION(HIN.LIN and SD) | I | 1 | | | |
| | | V _{DD} =3 V | 2.4 | | | V |
| V _{IH} | Logic "1" Input Voltage | V _{DD} =15 V | 9.5 | | | V |
| N/ | | V _{DD} =3 V | | | 0.8 | V |
| VIL | Logic "0" Input Voltage | V _{DD} =15 V | | | 6.0 | V |
| I _{IN+} | Logic "1" Input bias Current | V _{IN} =15 V | | 30 | 50 | μΑ |
| I _{IN-} | Logic "0" Input bias Current | V _{IN} =0 V | | | 1 | μΑ |
| R _{IN} | Logic Input Pull-down Resistance | | | 500 | | kΩ |
| GATE DRIV | /ER OUTPUT SECTION | | | | | |
| V _{OH} | High-Level Output Voltage, V _{BIAS} -V _O | I _O =0 A | | | 1.2 | V |
| V _{OL} | Low-Level Output Voltage, Vo | I _O =0 A | | | 0.1 | V |
| I _{O+} | Output HIGH Short-Circuit Pulse Current | V ₀ =0 V, V _{IN} =5 V with PW≤10 µs | | 2.0 | | Α |
| I _{O-} | Output LOW Short-Circuit Pulsed Current | V ₀ =15 V, V _{IN} =0 V with PW≤10 µs | | 3.0 | | Α |
| Vs | Allowable Negative $V_{\rm S}$ Pin Voltage for HIN Signal Propagation to HO | | | -9.8 | -7.0 | v |

DYNAMIC ELECTRICAL CHARACTERISTICS

$V_{\text{BLAS}}(V_{\text{CC}}, V_{\text{BS}}, V_{\text{DD}}) = 15.0 \text{ V}, V_{\text{S}} = V_{\text{SS}} = \text{COM}, C_{\text{L}} = 1000 \text{ pF} \text{ and } T_{\text{A}} = 25^{\circ}\text{C}, \text{ unless otherwise specified}$

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|--------------------|--|-------------------------|------|------|------|------|
| t _{on} | Turn-On Propagation Delay | V _S =0 V | | 500 | | ns |
| t _{OFF} | Turn-Off Propagation Delay | V _S =0V | | 550 | | ns |
| t _{FLTIN} | Input Filtering Time (HIN, LIN) (Note7) | | 80 | 150 | 220 | ns |
| t _{FLTSD} | Input Filtering Time (SD) | | | 30 | | ns |
| t _{SD} | Shutdown Propagation Delay Time | | 260 | 330 | 400 | ns |
| t _R | Turn-On Rise Time | | | 25 | | ns |
| t _F | Turn-Off Fall Time | | | 15 | | ns |
| DT | Dead Time | | 200 | 330 | 450 | ns |
| MDT | Dead-Time Matching (Note 8) | | | | 50 | ns |
| MT | Delay Matching , HO & LO Turn-On/OFF(Note 9) | | | | 50 | ns |
| PM | Output Pulse-Width Matching (Note 10) | PW _{IN} > 1 µs | | 50 | 100 | ns |

The minimum width of the input pulse should exceed 500 ns to ensure the filtering time of the input filter is exceeded.
MDT is defined as | DT_{HOLO}-DT_{LOHO}| referenced to Figure 40.
MT is defined as an absolute value of matching delay time between High-side and Low-side
PM is defined as an absolute value of matching pulse-width between Input and Output.



Figure 4 Turn-On Propagation Delay vs. Temperature



Figure 6 Turn-On Rise Time vs. Temperature



Figure 8 Turn-On Delay Matching vs. Temperature



Figure 5 Turn-Off Propagation Delay vs. Temperature



Figure 7 Turn-Off Fall Time vs. Temperature





































Figure 18 V_{CC} UVLO+ vs. Temperature



Figure 20 V_{BS} UVLO+ vs. Temperature







Figure 19 V_{CC} UVLO- vs. Temperature



Figure 21 V_{BS} UVLO- vs. Temperature











Figure 26 Allowable Negative V_S vs. Temperature











Figure 27 Input Logic(HIN&LIN) Threshold Voltage vs. V_{DD} Supply Voltage



Figure 28 Allowable Negative Vs Voltage for HIN Signal Propagation to High Side vs. V_{CC} Supply Voltage























vs. V_{DD} Supply Voltage







Figure 36 Output Pulse-Width Matching vs. VDD Supply Voltage

Switching Time Definitions





Switching Time Definitions (continued)

Figure 40. Internal Dead Time Definition



Figure 41. Switching Time Waveform Definitions





APPLICATIONS INFORMATION

Dead Time

Dead time is automatically inserted whenever the dead time of the external two input signals (between HIN and LIN signals) is shorter than internal fixed dead times (DT1 and DT2). Otherwise, external dead times larger than internal dead times are not modified by the gate driver and internal dead-time waveform definition is shown in Figure 43.



Figure 43. Internal Dead-Time Definitions

Protection Function

Shoot-Through Protection

The shoot-through protection circuitry prevents both high- and low-side switches from conducting at the same time, as shown in Figure 44.







Figure 44. Shoot-Through Protection

Shutdown Input

When the SD pin is in LOW state, the gate driver operates normally. When a condition occurs that should shut down the gate driver, the SD pin should be HIGH. The Shutdown circuitry has an input filter; the minimum input duration is specified by t_{FLTIN} (typically 250 ns).



Figure 45. Output Shutdown Timing Waveform

Noise Filter

Input Noise Filter

Figure 46 shows the input noise filter method, which has symmetry duration between the input signal (t_{INPUT}) and the output signal (t_{OUTPUT}) and helps to reject noise spikes and short pulses. This input filter is applied to the HIN, LIN, and EN inputs. The upper pair of waveforms (Example A) shows an input signal duration (t_{INPUT}) much longer than input filter time (t_{FLTIN}); it is approximately the same duration between the input signal time (t_{INPUT}) and the output signal time (t_{OUTPUT}). The lower pair of waveforms (Example B) shows an input signal time (t_{INPUT}) slightly longer than input filter time (t_{FLTIN}); it is approximately the same duration between input signal time (t_{INPUT}) and the output signal time (t_{OUTPUT}).



Figure 46. Input Noise Filter Definition

Short-Pulsed Input Noise Rejection Method

The input filter circuitry provides protection against short-pulsed input signals (HIN, LIN, and SD) on the input signal lines by applied noise signal.

If the input signal duration is less than input filter time (t_{FLTIN}), the output does not change states.

Example A and B of the Figure 47 show the input and output waveforms with short-pulsed noise spikes with a duration less than input filter time; the output does not change states.



Figure 47. Noise Rejecting Input Filter Definition

Negative VS Transient

The bootstrap circuit has the advantage of being simple and low cost, but has some limitations. The biggest difficulty with this circuit is the negative voltage present at the emitter of the high-side switching device when high-side switch is turned-off in half-bridge application. If the high-side switch, Q1, turns-off while the load current is flowing to an inductive load, a current commutation occurs from high-side switch, Q1, to the diode, D2, in parallel with the low-side switch of the same inverter leg. Then the negative voltage present at the emitter of the high-side switching device, just before the freewheeling diode, D2, starts clamping, causes load current to suddenly flow to the low-side freewheeling diode, D2, as shown in Figure 48.



Figure 48. Half-Bridge Application Circuits

This negative voltage can be trouble for the gate driver's output stage, there is the possibility to develop an overvoltage condition of the bootstrap capacitor, input signal missing and latch-up problems because it directly affects the source V_{s} pin of the gate driver, shown in Figure 49. This undershoot voltage is called "negative V_s transient".



Figure 49. V_s Waveforms during Q1 Turn-Off

Figure 50 and Figure 51 show the commutation of the load current between high-side switch, Q1, and low-side freewheeling diode, D3, in same inverter leg. The parasitic inductances in the inverter circuit from the die wire bonding to the PCB tracks are jumped together in L_{C} and L_{E} for each IGBT. When the high-side switch, Q1, and low-side switch, Q4, are turned on, the V_{S1} node is below DC+ voltage by the voltage drops associated with the power switch and the parasitic inductances of the circuit due to load current is flows from Q1 and Q4, as shown in Figure 50. When the high-side switch, Q1, is turned off and Q4, remained turned on, the load current to flows the low-side freewheeling diode, D3, due to the inductive load connected to VS1 as shown in Figure 51. Q1 Turn-Off and D3 Conducting. The current flows from ground (which is connected to the COM pin of the gate driver) to the load and the negative voltage present at the emitter of the high-side switching device. In this case, the COM pin of the gate driver is at a higher potential than the V_s pin due to the voltage drops associated with freewheeling diode, D3, and parasitic elements, L_{C3} and L_{E3}.



Figure 50. Q1 and Q4 Turn-On



Figure 51. Q1 Turn-Off and D3 Conducting

The FAN73912 has a typical negative V_{S} transient characteristics, as shown in Figure 52.



Figure 52. Negative V_S Transient Characteristic

Even though the FAN73912 has been shown able to handle these negative V_s transient conditions, it is strongly recommended that the circuit designer limit the negative V_s transient as much as possible by careful PCB layout to minimize the value of parasitic elements and component use. The amplitude of negative V_s voltage is proportional to the parasitic inductances and the turn-off speed, di/dt, of the switching device.

General Guidelines

Printed Circuit Board Layout

The layout recommended for minimized parasitic elements is as follows:

- Direct tracks between switches with no loops or deviation.
- Avoid interconnect links. These can add significant inductance.
- Reduce the effect of lead-inductance by lowering package height above the PCB.

- Consider co-locating both power switches to reduce track length.
- To minimize noise coupling, the ground plane should not be placed under or near the high-voltage floating side.
- To reduce the EM coupling and improve the power switch turn-on/off performance, the gate drive loops must be reduced as much as possible.

Placement of Components

The recommended placement and selection of component as follows:

- Place a bypass capacitor between the V_{CC} and V_{SS} pins. A ceramic 1 μ F capacitor is suitable for most applications. This component should be placed as close as possible to the pins to reduce parasitic elements.
- The bypass capacitor from V_{CC} to V_{SS} supports both the low-side driver and bootstrap capacitor recharge. A value at least ten times higher than the bootstrap capacitor is recommended.
- The bootstrap resistor, R_{BOOT} , must be considered in sizing the bootstrap resistance and the current developed during initial bootstrap charge. If the resistor is needed in series with the bootstrap diode, verify that V_B does not fall below COM (ground). Recommended use is typically $5 \sim 10 \Omega$ that increase the V_{BS} time constant. If the voltage drop of bootstrap resistor and diode is too high or the circuit topology does not allow a sufficient charging time, a fast recovery or ultra-fast recovery diode can be used.
- The bootstrap capacitor, C_{BOOT}, uses a low-ESR capacitor, such as ceramic capacitor. It is strongly recommended that the placement of components is as follows:
- Place components tied to the floating voltage pins (V_B and V_S) near the respective high-voltage portions of the device and the FAN73912. Not Connected (NC) pins in this package maximize the distance between the high-voltage and low-voltage pins (see Figure 3)
- Place and route for bypass capacitors and gate resistors as close as possible to gate drive IC.
- Locate the bootstrap diode, D_{BOOT}, as close as possible to bootstrap capacitor, C_{BOOT}.
- The bootstrap diode must use a lower forward voltage drop and minimal switching time as soon as possible for fast recovery or ultra-fast diode.

PACKAGE DIMENSIONS



Figure 53. 16-Lead, Small Outline Package(SOP)

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